

<b>Notice of References Cited</b>	Application/Control No. 10/821,106	Applicant(s)/Patent Under Reexamination VIITAMAKI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0030307	02-2006	Cadieux et al.	455/418
*	B	US-2005/0013264	01-2005	Sundberg, Per-Erik	370/328
*	C	US-2006/0183423	08-2006	Johansson et al.	455/041.2
*	D	US-2006/0089119	04-2006	Lipasti et al.	455/410
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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